## Application/Control No. Applicant(s)/Patent Under Reexamination 10/076,620 BEN-GAL ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2123 Ayal I. Sharon **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY US-Α US-В US-С US-D US-Ε US-F US-G US-Н US-US-J US-K US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Country Code-Number-Kind Code Classification MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS**

| * |   | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)  |
|---|---|--|
| i | υ | "Advanced Summer Institute 2000: The Annual Conference of the ICIMS-NOE (E.P. 23447)". Printed 8/23/06. http://www.lar.ee.upatras.gr/icims/asi/asi2000/asi2000.htm |
|   | V |  |
|   | w |  |
|   | × |  |

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.